

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ANDOH ET AL.	
		Examiner Toniae M. Thomas	Art Unit 2822	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0171093 A1	11-2002	Onishi et al.	257/197
	B	US-4,009,483	02-1977	Clark, Lowell E.	257/489
	C	US-4,220,963	09-1980	Rumennik, Vladimir	257/619
	D	US-4,925,812	05-1990	Gould, Herbert J.	438/543
	E	US-5,283,202	02-1994	Pike et al.	438/543
	F	US-5,466,612	11-1995	Fuse et al.	438/60
	G	US-5,552,625	09-1996	Murakami et al.	257/409
	H	US-6,197,649 B1	03-2001	Francis et al.	438/380
	I	US-6,441,455 B1	08-2002	Dutta, Ranadeep	257/490
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.